Application/Control No. 10/777,069 Applicant(s)/Patent Under Reexamination OOISHI, TSUKASA Examiner Ly D. Pham Applicant(s)/Patent Under Reexamination OOISHI, TSUKASA Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0198080 A1	10-2003	lwata, Yoshihisa	365/158
*	В	US-2003/0161180 A1	08-2003	Bloomquist et al.	365/173
*	С	US-2003/0156448 A1	08-2003	Hidaka, Hideto	365/171
*	D	US-2003/0117838 A1	06-2003	Hidaka, Hideto	365/171
*	Е	US-2002/0057593 A1	05-2002	Hidaka, Hideto	365/171
*	F	US-6,876,575 B2	04-2005	Hidaka, Hideto	365/171
*	G	US-6,741,513 B2	05-2004	Honigschmid et al.	365/158
*	Н	US-6,611,454 B2	08-2003	Hidaka, Hideto	365/171
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	œ					
	R					•
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.